

# STV200N55F3

## N-channel 55 V, 1.8 mΩ, 200 A, PowerSO-10 STripFET<sup>™</sup> Power MOSFET

### **Features**

Туре	V <sub>DSS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub> <sup>(1)</sup>
STV200N55F3	55 V	< 2.5 mΩ	200 A

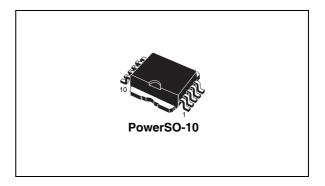
- 1. Current limited by package
- Conduction losses reduced
- Low profile, very low parasitic inductance

### Application

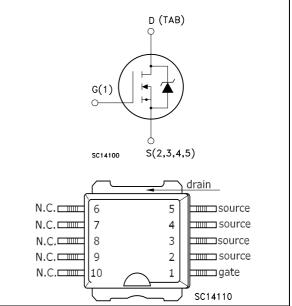
Switching applications

### Description

This n-channel enhancement mode Power MOSFET is the latest refinement of ST's STripFET™ process. The resulting transistor shows extremely high packing density for low on resistance, rugged avalanche characteristics and low gate charge.



#### Figure 1. Internal schematic diagram and connection diagram (top view)



#### Table 1. **Device summary**

Order code	Marking	Package	Packaging
STV200N55F3	200N55F3	PowerSO-10	Tape and reel

November	2008
NOVEINDEI	2000

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# 1 Electrical ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage (v <sub>gs</sub> = 0)	55	V
V <sub>GS</sub>	Gate-source voltage	± 20	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	200	А
۱ <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	170	А
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	800	A
P <sub>TOT</sub> <sup>(3)</sup>	Total dissipation at $T_{C}$ = 25 °C	300	w
	Derating factor	2.0	W/°C
E <sub>AS</sub> <sup>(4)</sup>	Single pulse avalanche energy	1.0	J
T <sub>stg</sub>	Storage temperature	-55 to 175	°C
Тj	Operating junction temperature	-55 10 175	

1. Current limited by package

2. Pulse width limited by safe operating area

3. This value is rated according to Rthj-c

4. Starting Tj = 25 °C,  $I_D$  = 60 A,  $V_{DD}$  = 35 V

	Table	3.	Thermal	data
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Symbol Parameter		Value	Unit
Rthj-case	Thermal resistance junction-case max	0.5	°C/W
Rthj-pcb <sup>(1)</sup>	Thermal resistance junction-pcb max	50	°C/W

1. When mounted on 1 inch<sup>2</sup> FR-4 2 oz Cu



# 2 Electrical characteristics

(T<sub>case</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_{\rm D} = 250 \ \mu \text{A}, \ V_{\rm GS} = 0$	55			V
I <sub>DSS</sub>	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS}$ = Max rating, $V_{DS}$ = Max rating, $T_c$ = 125 °C			1 10	μΑ μΑ
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>DS</sub> = ± 20 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2		4	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 75 A		1.8	2.5	mΩ

### Table 4. On /off states

#### Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> = 25 V, f = 1 MHz, V <sub>GS</sub> =0		6800 1450 15		pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 44 \text{ V}, I_D = 120 \text{ A},$ $V_{GS} = 10 \text{ V}$ (see Figure 14)		100 30 26		nC nC nC

	•					
Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
t <sub>d(on)</sub> t <sub>r</sub>	Turn-on delay time Rise time	$V_{DD} = 27.5 \text{ V}, I_D = 60 \text{ A}$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V},$ <i>(see Figure 13)</i>		25 150		ns ns
t <sub>d(off)</sub> t <sub>f</sub>	Turn-off delay time Fall time	$V_{DD} = 27.5 \text{ V}, I_D = 60 \text{ A}$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V},$ <i>(see Figure 13)</i>		110 50		ns ns

Table 6.Switching times

#### Table 7.Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub> I <sub>SD</sub> <sup>(1)</sup>	Source-drain current Source-drain current (pulsed)				200 800	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 120 A, V <sub>GS</sub> = 0			1.5	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 120 \text{ A,di/dt} = 100 \text{ A/µs}$ $V_{DD} = 35 \text{ V, } T_j = 150 \text{ °C}$ <i>(see Figure 18)</i>		60 110 3.5		ns nC A

1. Pulse width limited by safe operating area

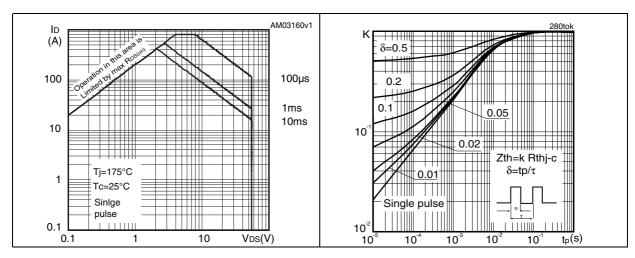
2. Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5%



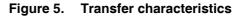
## 2.1 Electrical characteristics (curves)

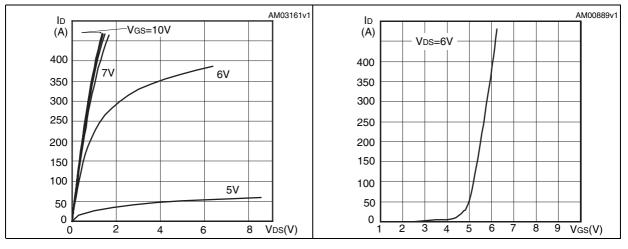
### Figure 2. Safe operating area

Figure 3. Thermal impedance









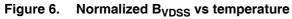
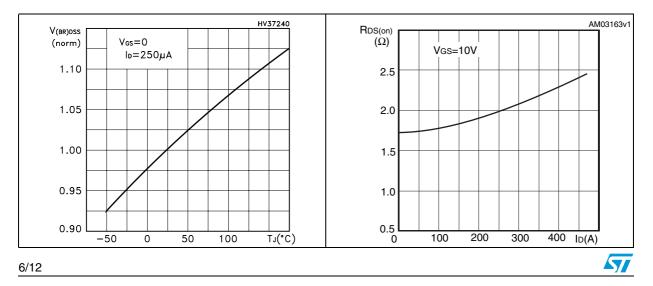
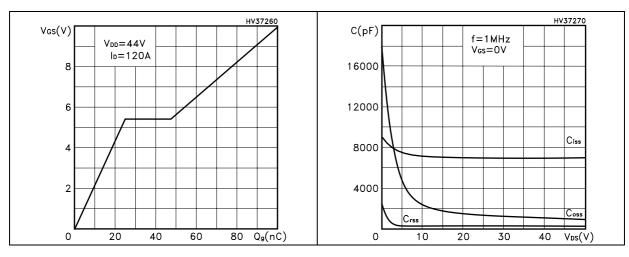


Figure 7. Static drain-source on resistance





### Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage vs temperature

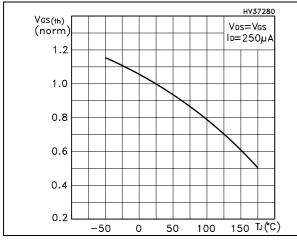


Figure 12. Source-drain diode forward characteristics

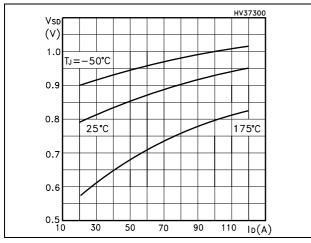
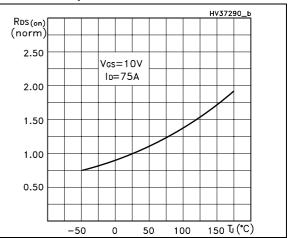


Figure 11. Normalized on resistance vs temperature



## 3 Test circuits

Figure 13. Switching times test circuit for resistive load

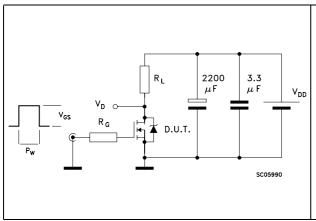
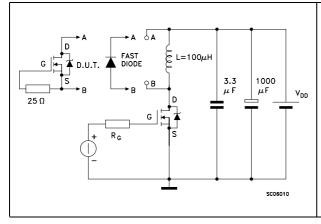


Figure 15. Test circuit for inductive load switching and diode recovery times





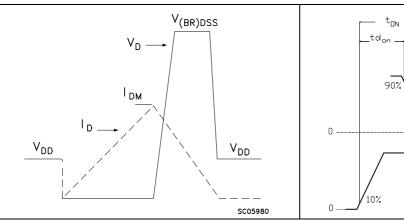
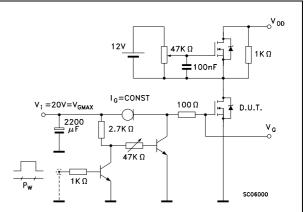
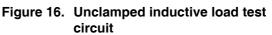


Figure 14. Gate charge test circuit





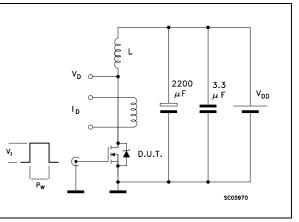
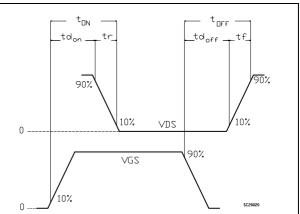


Figure 18. Switching time waveform



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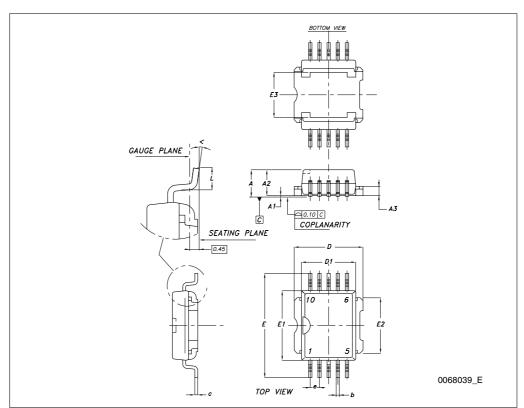
### 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: *www.st.com* 



Dim	mm		
	Min	Тур	Мах
Α			3.70
A1	0.00		0.10
A2	3.40		3.60
A3	1.25		1.35
b	0.40		0.53
С	0.35		0.55
D	9.40		9.60
D1	7.40		7.60
E	13.80		14.40
E1	9.30		9.50
E2	7.20		7.60
E3	5.90		6.10
е		1.27	
L	0.95		1.65
<	0 <sup>0</sup>		8 <sup>0</sup>





# 5 Revision history

### Table 8. Document revision history

Date	Revision	Changes	
05-Mar-2008	1	First release.	
10-Nov-2008	2	Document status promoted from preliminary to datasheet.	



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